

# RF LDMOS Wideband Integrated Power Amplifier

The MW7IC008N wideband integrated circuit is designed with on-chip matching that makes it usable from 20 to 1000 MHz. This multi-stage structure is rated for 24 to 32 volt operation and covers most narrow bandwidth communication application formats.

## Driver Applications

- Typical CW Performance:  $V_{DD} = 28$  Volts,  $I_{DQ1} = 25$  mA,  $I_{DQ2} = 75$  mA

| Frequency          | $G_{ps}$ (dB) | PAE (%) |
|--------------------|---------------|---------|
| 100 MHz @ 11 W CW  | 23.5          | 55      |
| 400 MHz @ 9 W CW   | 22.5          | 41      |
| 900 MHz @ 6.5 W CW | 23.5          | 34      |

- Capable of Handling 10:1 VSWR, @ 32 Vdc, 900 MHz,  $P_{out} = 6.5$  Watts CW (3 dB Input Overdrive from Rated  $P_{out}$ )
- Stable into a 5:1 VSWR. All Spurs Below -60 dBc @ 1 mW to 8 Watts CW  $P_{out}$  @ 900 MHz
- Typical  $P_{out}$  @ 1 dB Compression Point  $\approx$  11 Watts CW @ 100 MHz, 9 Watts CW @ 400 MHz, 6.5 Watts CW @ 900 MHz

## Features

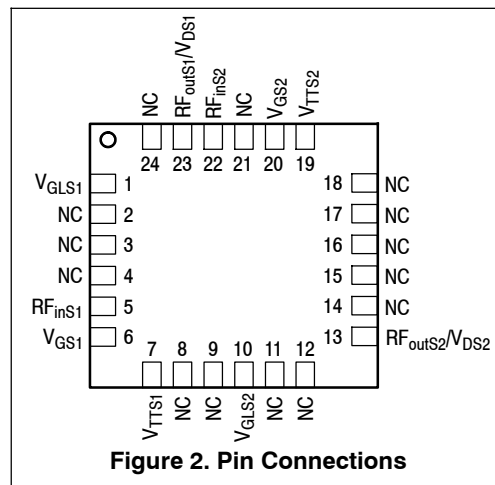
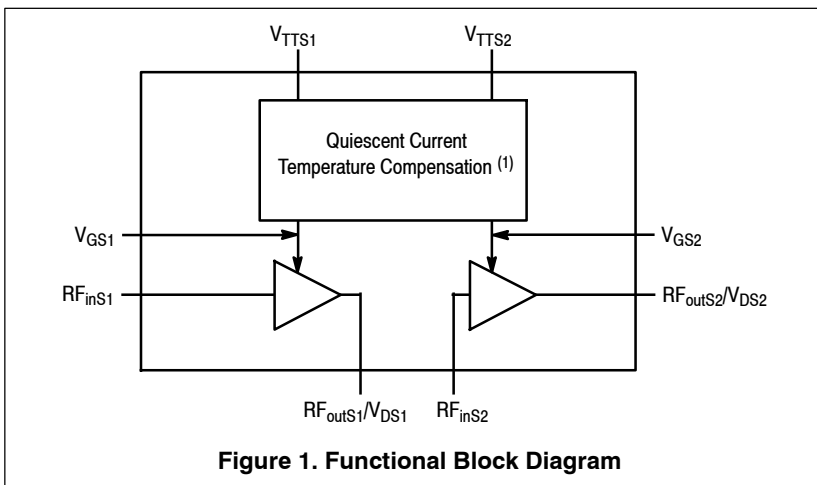
- Broadband, Single Matching Network from 20 to 1000 MHz
- Integrated Quiescent Current Temperature Compensation with Enable/Disable Function (1)
- Integrated ESD Protection
- In Tape and Reel. T1 Suffix = 1,000 Units, 16 mm Tape Width, 13-inch Reel.

**MW7IC008NT1**

**100-1000 MHz, 8 W PEAK, 28 V  
RF LDMOS WIDEBAND  
INTEGRATED POWER AMPLIFIER**



**PQFN 8 x 8  
PLASTIC**



1. Refer to AN1977, *Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family* and to AN1987, *Quiescent Current Control for the RF Integrated Circuit Device Family*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1977 or AN1987.

**Table 1. Maximum Ratings**

| Rating   | Symbol    | Value                         | Unit           |
|--|-----------|-------------------------------|----------------|
| Drain-Source Voltage   | $V_{DSS}$ | -0.5, +65                     | Vdc            |
| Gate-Source Voltage  | $V_{GS}$  | -6.0, +12                     | Vdc            |
| Operating Voltage  | $V_{DD}$  | 32, +0                        | Vdc            |
| Storage Temperature Range                                      | $T_{stg}$ | -65 to +150                   | °C             |
| Operating Junction Temperature                                 | $T_J$     | 150                           | °C             |
| 100 MHz CW Operation @ $T_A = 25^\circ\text{C}$ <sup>(3)</sup> | CW        | 11                            | W              |
| 400 MHz CW Operation @ $T_A = 25^\circ\text{C}$ <sup>(3)</sup> |           | 6                             | W              |
| 900 MHz CW Operation @ $T_A = 25^\circ\text{C}$ <sup>(3)</sup> |           | 5                             | W              |
| Input Power  | $P_{in}$  | 100 MHz<br>400 MHz<br>900 MHz | 27<br>23<br>38 |
|  |           |                               | dBm            |
|  |           |                               |                |

**Table 2. Thermal Characteristics**

| Characteristic   | Symbol          | Value (1,2)  | Unit       |
|--|-----------------|--|------------|
| Thermal Resistance, Junction to Case                                   | $R_{\theta JC}$ |  | °C/W       |
| (CW Signal @ 100 MHz)<br>(Case Temperature 82°C, $P_{out} = 11$ W CW)  |                 | Stage 1, 28 Vdc, $I_{DQ1} = 25$ mA<br>Stage 2, 28 Vdc, $I_{DQ2} = 75$ mA | 5.3<br>4.9 |
| (CW Signal @ 400 MHz)<br>(Case Temperature 87°C, $P_{out} = 9$ W CW)   |                 | Stage 1, 28 Vdc, $I_{DQ1} = 25$ mA<br>Stage 2, 28 Vdc, $I_{DQ2} = 75$ mA | 4.4<br>2.7 |
| (CW Signal @ 900 MHz)<br>(Case Temperature 86°C, $P_{out} = 6.5$ W CW) |                 | Stage 1, 28 Vdc, $I_{DQ1} = 25$ mA<br>Stage 2, 28 Vdc, $I_{DQ2} = 75$ mA | 3.5<br>3.2 |
|  |                 |  |            |
|  |                 |  |            |

**Table 3. ESD Protection Characteristics**

| Test Methodology                      | Class |
|---------------------------------------|-------|
| Human Body Model (per JESD22-A114)    | 1B    |
| Machine Model (per EIA/JESD22-A115)   | A     |
| Charge Device Model (per JESD22-C101) | III   |

**Table 4. Moisture Sensitivity Level**

| Test Methodology                     | Rating | Package Peak Temperature | Unit |
|--------------------------------------|--------|--------------------------|------|
| Per JESD22-A113, IPC/JEDEC J-STD-020 | 3      | 260                      | °C   |

1. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.
3. CW Ratings at the individual frequencies are limited by a 100-year MTTF requirement. See MTTF calculator (referenced in Note 1).

**Table 5. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

| Characteristic  | Symbol    | Min | Typ | Max | Unit            |
|---|-----------|-----|-----|-----|-----------------|
| <b>Stage 1 — Off Characteristics</b>  |           |     |     |     |                 |
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 65\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | —   | —   | 10  | $\mu\text{Adc}$ |
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | —   | —   | 1   | $\mu\text{Adc}$ |
| Gate-Source Leakage Current<br>( $V_{GS} = 1.5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )            | $I_{GSS}$ | —   | —   | 10  | $\mu\text{Adc}$ |

**Stage 1 — On Characteristics**

|  |              |     |     |     |     |
|--|--------------|-----|-----|-----|-----|
| Gate Threshold Voltage<br>( $V_{DS} = 10\text{ Vdc}$ , $I_D = 5.3\ \mu\text{Adc}$ )                          | $V_{GS(th)}$ | 1.3 | 2   | 2.8 | Vdc |
| Gate Quiescent Voltage<br>( $V_{DD} = 28\text{ Vdc}$ , $I_D = 25\text{ mAdc}$ , Measured in Functional Test) | $V_{GS(Q)}$  | 2   | 2.8 | 3.5 | Vdc |

**Stage 2 — Off Characteristics**

|   |           |   |   |    |                 |
|---|-----------|---|---|----|-----------------|
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 65\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | — | — | 10 | $\mu\text{Adc}$ |
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | — | — | 1  | $\mu\text{Adc}$ |
| Gate-Source Leakage Current<br>( $V_{GS} = 1.5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )            | $I_{GSS}$ | — | — | 10 | $\mu\text{Adc}$ |

**Stage 2 — On Characteristics**

|  |              |     |     |     |     |
|--|--------------|-----|-----|-----|-----|
| Gate Threshold Voltage<br>( $V_{DS} = 10\text{ Vdc}$ , $I_D = 23\ \mu\text{Adc}$ )                           | $V_{GS(th)}$ | 1.3 | 2   | 2.8 | Vdc |
| Gate Quiescent Voltage<br>( $V_{DD} = 28\text{ Vdc}$ , $I_D = 75\text{ mAdc}$ , Measured in Functional Test) | $V_{GS(Q)}$  | 2   | 2.7 | 3.5 | Vdc |
| Drain-Source On-Voltage<br>( $V_{GS} = 10\text{ Vdc}$ , $I_D = 3.6\text{ Adc}$ )                             | $V_{DS(on)}$ | 0.1 | 0.3 | 1   | Vdc |

**Functional Tests** <sup>(1)</sup> (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ1} = 25\text{ mA}$ ,  $I_{DQ2} = 75\text{ mA}$ ,  $P_{out} = 6.5\text{ W CW}$ ,  $f = 900\text{ MHz}$ 

|                        |          |      |      |      |    |
|------------------------|----------|------|------|------|----|
| Power Gain             | $G_{ps}$ | 21.5 | 23.5 | 31.5 | dB |
| Power Added Efficiency | PAE      | 30   | 34   | —    | %  |
| Input Return Loss      | IRL      | —    | -15  | -11  | dB |

**Typical Broadband Performance** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ1} = 25\text{ mA}$ ,  $I_{DQ2} = 75\text{ mA}$ 

| Frequency          | $G_{ps}$<br>(dB) | PAE<br>(%) | IRL<br>(dB) |
|--------------------|------------------|------------|-------------|
| 100 MHz @ 11 W CW  | 23.5             | 55         | -20         |
| 400 MHz @ 9 W CW   | 22.5             | 41         | -17         |
| 900 MHz @ 6.5 W CW | 23.5             | 34         | -15         |

1. Part internally matched both on input and output.

(continued)

**Table 5. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (continued)

| Characteristic   | Symbol               | Min | Typ   | Max | Unit                 |
|--|----------------------|-----|-------|-----|----------------------|
| <b>Typical Performances</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$ , $I_{DQ1} = 25\text{ mA}$ , $I_{DQ2} = 75\text{ mA}$ , 100–1000 MHz Bandwidth                     |                      |     |       |     |                      |
| Characteristic   | Symbol               | Min | Typ   | Max | Unit                 |
| IMD Symmetry @ 6.8 W PEP, $P_{out}$ where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ <sup>(1)</sup><br>(Delta IMD Third Order Intermodulation between Upper and Lower Sidebands > 2 dB) | $IMD_{sym}$          | —   | 0.1   | —   | MHz                  |
| VBW Resonance Point <sup>(1)</sup><br>(IMD Third Order Intermodulation Inflection Point)   | $VBW_{res}$          | —   | 0.1   | —   | MHz                  |
| Gain Flatness in 500–1000 MHz Bandwidth @ $P_{out} = 6\text{ W Avg.}$  | $G_F$                | —   | 1.35  | —   | dB                   |
| Gain Variation over Temperature<br>( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )  | $\Delta G$           | —   | 0.024 | —   | dB/ $^\circ\text{C}$ |
| Output Power Variation over Temperature<br>( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )  | $\Delta P1\text{dB}$ | —   | 0.005 | —   | dB/ $^\circ\text{C}$ |

**Typical CW Performances — 100 MHz** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ1} = 25\text{ mA}$ ,  $I_{DQ2} = 75\text{ mA}$ ,  $P_{out} = 11\text{ W}$  CW,  $f = 100\text{ MHz}$

|  |          |   |      |   |    |
|--|----------|---|------|---|----|
| Power Gain                             | $G_{ps}$ | — | 23.5 | — | dB |
| Power Added Efficiency                 | PAE      | — | 55   | — | %  |
| Input Return Loss                      | IRL      | — | -20  | — | dB |
| $P_{out}$ @ 1 dB Compression Point, CW | P1dB     | — | 11   | — | W  |

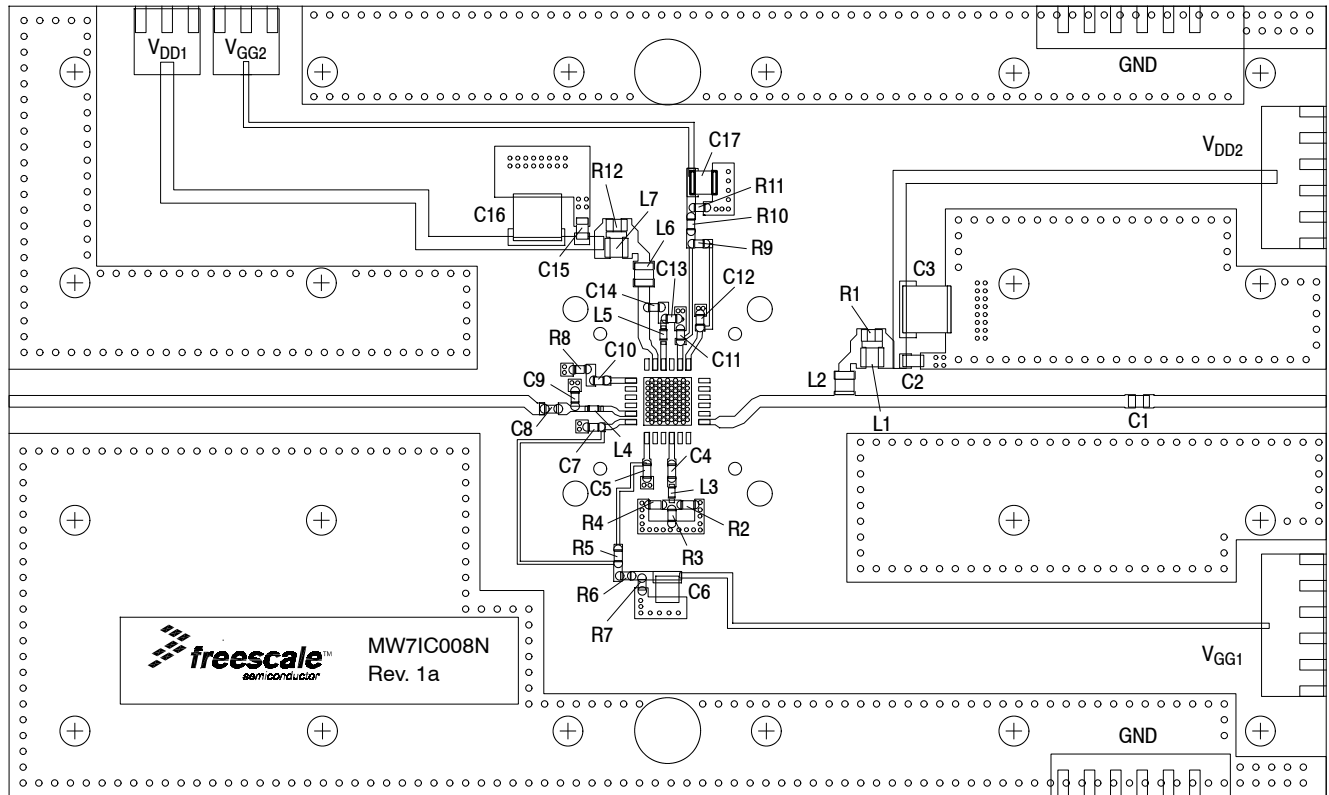
**Typical CW Performances — 400 MHz** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ1} = 25\text{ mA}$ ,  $I_{DQ2} = 75\text{ mA}$ ,  $P_{out} = 9\text{ W}$  CW,  $f = 400\text{ MHz}$

|  |          |   |      |   |    |
|--|----------|---|------|---|----|
| Power Gain                             | $G_{ps}$ | — | 22.5 | — | dB |
| Power Added Efficiency                 | PAE      | — | 41   | — | %  |
| Input Return Loss                      | IRL      | — | -17  | — | dB |
| $P_{out}$ @ 1 dB Compression Point, CW | P1dB     | — | 9    | — | W  |

**Typical CW Performances — 900 MHz** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ1} = 25\text{ mA}$ ,  $I_{DQ2} = 75\text{ mA}$ ,  $P_{out} = 6.5\text{ W}$  CW,  $f = 900\text{ MHz}$

|  |          |   |      |   |    |
|--|----------|---|------|---|----|
| Power Gain                             | $G_{ps}$ | — | 23.5 | — | dB |
| Power Added Efficiency                 | PAE      | — | 34   | — | %  |
| Input Return Loss                      | IRL      | — | -15  | — | dB |
| $P_{out}$ @ 1 dB Compression Point, CW | P1dB     | — | 6.5  | — | W  |

1. Not recommended for wide instantaneous bandwidth modulated signals.



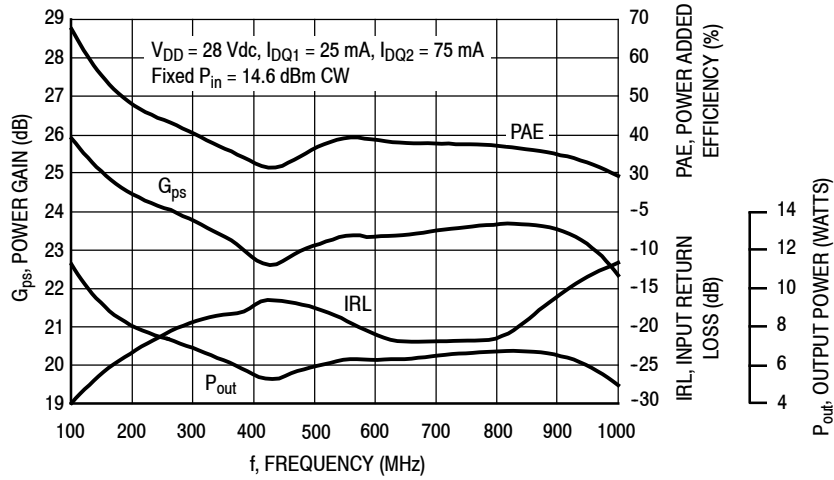
**Figure 3. MW71C008NT1 Test Circuit Component Layout**

**Table 6. MW71C008NT1 Test Circuit Component Designations and Values**

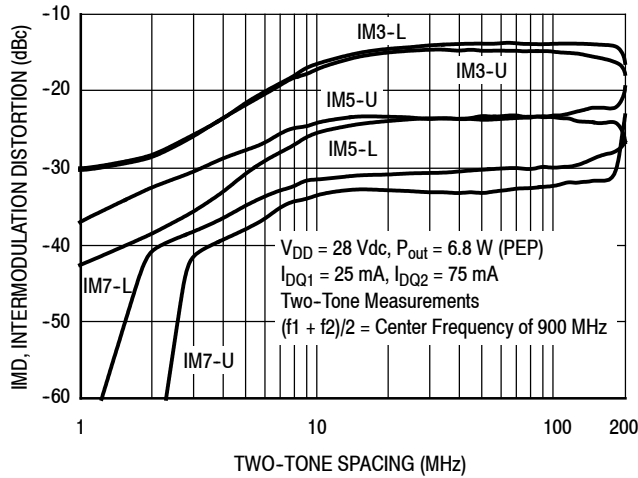
| Part                               | Description                          | Part Number        | Manufacturer |
|------------------------------------|--------------------------------------|--------------------|--------------|
| C1                                 | 0.01 $\mu$ F Chip Capacitor          | GRM3195C1E103JA01  | Murata       |
| C2, C15                            | 0.1 $\mu$ F Chip Capacitors          | GRM219F51H104ZA01  | Murata       |
| C3, C16                            | 10 $\mu$ F Chip Capacitors           | GRM55DR61H106KA88L | Murata       |
| C4, C5, C7, C8, C10, C11, C12, C14 | 0.01 $\mu$ F Chip Capacitors         | C0805C103K5RAC     | Kemet        |
| C6, C17                            | 1 $\mu$ F, 35 V Tantalum Capacitors  | TAJA105K035R       | AVX          |
| C9                                 | 2.2 pF Chip Capacitor                | ATC600S2R2CT250XT  | ATC          |
| C13                                | 3.3 pF Chip Capacitor                | ATC600S3R3BT250XT  | ATC          |
| L1, L7                             | 150 nH Ceramic Chip Inductors        | LL2012-FHLR15J     | Toko         |
| L2, L6                             | 180 nH Ceramic Chip Inductors        | LL2012-FHLR18J     | Toko         |
| L3                                 | 1.6 nH Inductor                      | 0603HC-1N6XJLW     | Coilcraft    |
| L4, L5                             | 5.1 nH Inductors                     | 0603HP-5N1XJLW     | Coilcraft    |
| R1, R12                            | 510 $\Omega$ , 1/10 W Chip Resistors | RR1220P-511-B-T5   | Susumu       |
| R2, R3, R4                         | 91 $\Omega$ , 1/8 W Chip Resistors   | CRCW080591R0FKEA   | Vishay       |
| R5*, R9*                           | 0 $\Omega$ , 2.5 A Chip Resistors    | CRCW08050000Z0EA   | Vishay       |
| R6                                 | 10 K $\Omega$ , 1/8 W Chip Resistor  | CRCW080510K0JNEA   | Vishay       |
| R7, R11                            | 12 K $\Omega$ , 1/8 W Chip Resistors | CRCW080512K0JNEA   | Vishay       |
| R8                                 | 43 $\Omega$ , 1/8 W Chip Resistor    | CRCW080543R0FKEA   | Vishay       |
| R10                                | 15 K $\Omega$ , 1/8 W Chip Resistor  | CRCW080515K0JNEA   | Vishay       |
| PCB                                | 0.020", $\epsilon_r = 3.66$          | RO4350B            | Rogers       |

\*Add for temperature compensation

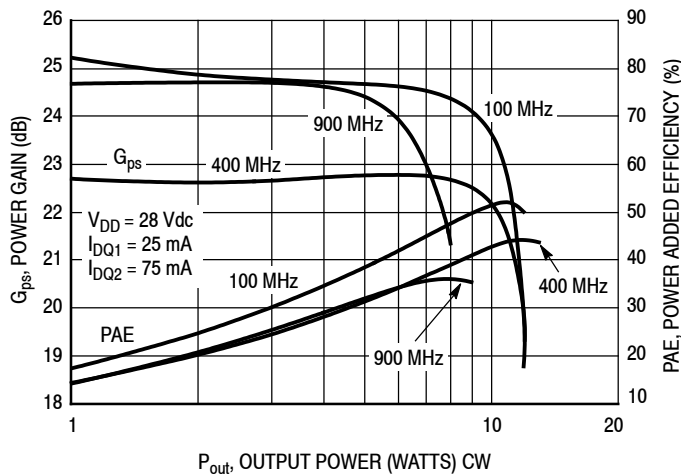
### TYPICAL CHARACTERISTICS



**Figure 4. Broadband Performance @  $P_{in} = 14.6 \text{ dBm CW}$**

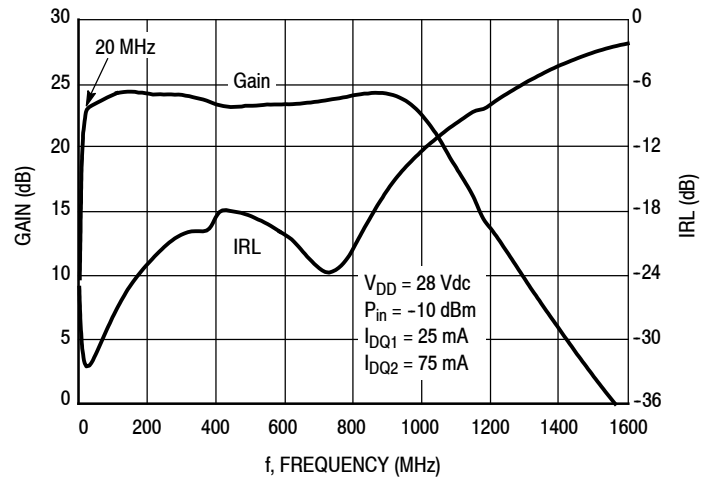


**Figure 5. Intermodulation Distortion Products versus Two-Tone Spacing**



**Figure 6. Power Gain and Power Added Efficiency versus Output Power**

### TYPICAL CHARACTERISTICS



**Figure 7. Broadband Frequency Response**

$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ1} = 25 \text{ mA}$ ,  $I_{DQ2} = 75 \text{ mA}$   
 $P_{out} = 11 \text{ W @ } 100 \text{ MHz}$ ,  $9 \text{ W @ } 400 \text{ MHz}$ ,  $6.5 \text{ W @ } 900 \text{ MHz}$

| f<br>MHz | $Z_{in}$<br>$\Omega$ | $Z_{load}$<br>$\Omega$ |
|----------|----------------------|------------------------|
| 100      | 49.78 + j1.07        | 47.87 - j9.85          |
| 150      | 48.96 + j1.44        | 49.12 - j5.44          |
| 200      | 48.00 + j1.54        | 49.09 - j2.66          |
| 250      | 46.67 + j1.36        | 48.63 - j0.79          |
| 300      | 45.30 + j0.91        | 47.73 + j0.49          |
| 350      | 43.93 + j0.11        | 46.60 + j1.22          |
| 400      | 42.53 - j0.86        | 45.63 + j1.43          |
| 450      | 41.38 - j2.16        | 44.97 + j1.13          |
| 500      | 40.30 - j3.71        | 45.04 + j0.70          |
| 550      | 39.38 - j5.44        | 45.23 + j0.77          |
| 600      | 38.43 - j7.11        | 44.80 + j1.29          |
| 650      | 37.94 - j8.71        | 44.32 + j1.48          |
| 700      | 37.49 - j10.52       | 43.57 + j1.51          |
| 750      | 37.31 - j12.42       | 43.19 + j1.32          |
| 800      | 37.00 - j14.03       | 42.61 + j0.77          |
| 850      | 36.74 - j15.64       | 42.25 + j0.39          |
| 900      | 36.57 - j17.09       | 41.90 + j0.03          |
| 950      | 36.37 - j18.59       | 41.67 - j0.41          |
| 1000     | 36.12 - j20.06       | 41.77 - j1.10          |
| 1050     | 35.58 - j21.43       | 41.82 - j1.60          |
| 1100     | 35.00 - j22.79       | 41.90 - j2.01          |
| 1150     | 34.53 - j24.39       | 42.26 - j2.43          |
| 1200     | 33.53 - j25.97       | 42.51 - j2.80          |
| 1250     | 32.67 - j27.84       | 42.74 - j2.99          |
| 1300     | 31.61 - j29.89       | 43.10 - j3.11          |
| 1350     | 30.61 - j32.34       | 43.52 - j3.19          |
| 1400     | 29.55 - j34.81       | 43.86 - j3.13          |
| 1450     | 28.23 - j37.61       | 44.03 - j3.03          |
| 1500     | 27.34 - j40.59       | 44.33 - j2.67          |

$Z_{in}$  = Device input impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

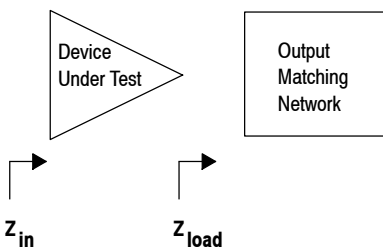
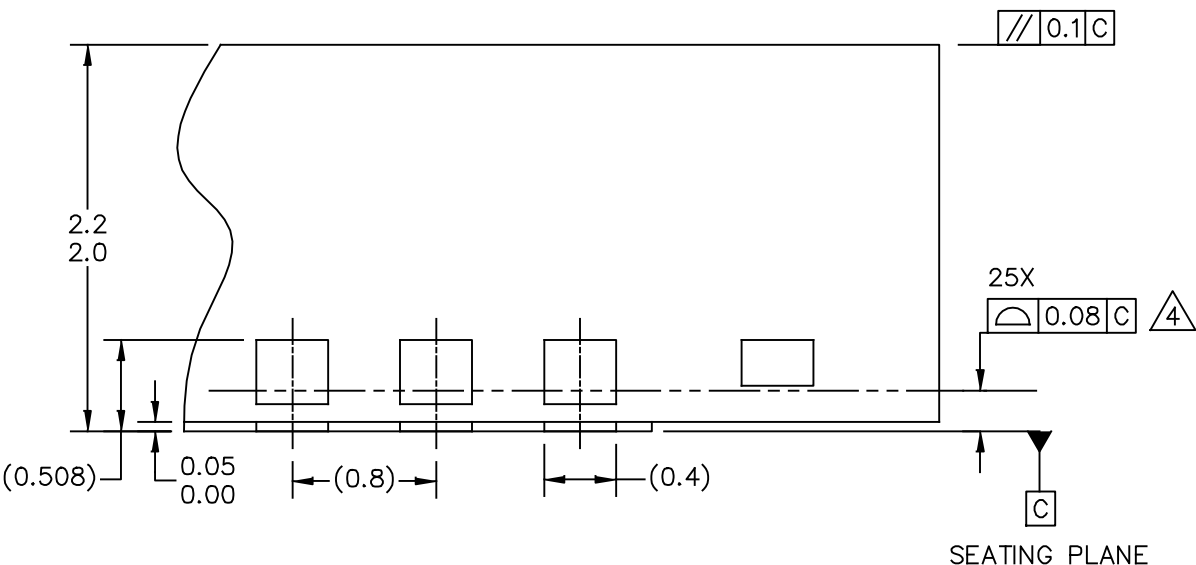


Figure 8. Series Equivalent Input and Load Impedance








DETAIL G  
VIEW ROTATED 90° CW

|   |                          |                            |  |
|---|--------------------------|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED.                         | MECHANICAL OUTLINE       | PRINT VERSION NOT TO SCALE |  |
| TITLE:<br>PQFN (SAW), THERMALLY ENHANCED<br>8 X 8 X 2.1, 0.8 PITCH, 24 TERMINAL | DOCUMENT NO: 98ASA10760D | REV: A                     |  |
|   | CASE NUMBER: 1894-02     | 29 MAY 2012                |  |
|   | STANDARD: NON-JEDEC      |                            |  |

NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
3. THE COMPLETE JEDEC DESIGNATOR FOR THIS PACKAGE IS: HF-PQFN.
4.  COPLANARITY APPLIES TO LEADS AND DIE ATTACH PAD.

|   |                          |                            |  |
|---|--------------------------|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED.                         | MECHANICAL OUTLINE       | PRINT VERSION NOT TO SCALE |  |
| TITLE:<br>PQFN (SAW), THERMALLY ENHANCED<br>8 X 8 X 2.1, 0.8 PITCH, 24 TERMINAL | DOCUMENT NO: 98ASA10760D | REV: A                     |  |
|   | CASE NUMBER: 1894-02     | 29 MAY 2012                |  |
|   | STANDARD: NON-JEDEC      |                            |  |

Refer to the following documents and software to aid your design process.

**Application Notes**

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN1977 Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family
- AN1987 Quiescent Current Control for the RF Integrated Circuit Device Family

**Engineering Bulletins**

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

**Software**

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

**REVISION HISTORY**

The following table summarizes revisions to this document.

| Revision | Date       | Description   |
|----------|------------|---|
| 0        | Aug. 2009  | <ul style="list-style-type: none"> <li>• Initial Release of Data Sheet</li> </ul>   |
| 1        | Sept. 2009 | <ul style="list-style-type: none"> <li>• Modified Fig. 3, Test Circuit Component Layout and Table 6, Test Circuit Component Designations and Values to include temperature compensation options, p. 5</li> <li>• Fig. 3, Test Circuit Component Layout, corrected <math>V_{DD1}</math> to <math>V_{GG1}</math>, p. 5</li> <li>• Table 6, Test Circuit Component Designations and Values, C6, C17: updated description from “1 <math>\mu</math>F Tantalum Capacitors” to “1 <math>\mu</math>F, 35 V Tantalum Capacitors”; L1, L7, L2, L6: corrected manufacturer from Coilcraft to Toko; L3: corrected part number from “0603HC-1N6XJLC” to “0603HC-1N6XJLW”; L4, L5: corrected part number from “100B100JT500XT” to “0603HP-5N1XJLW”; R1, R12: updated description from “510 <math>\Omega</math> Chip Resistors” to “510 <math>\Omega</math>, 1/10 W Chip Resistors”, p. 5</li> </ul> |
| 2        | Mar. 2011  | <ul style="list-style-type: none"> <li>• Updated frequency in overview paragraph from “100 to 1000 MHz” to “20 to 1000 MHz” to reflect lower 20 MHz capability and narrow bandwidth modulation, p. 1</li> <li>• Updated <math>IMD_{sym}</math> Typical value from 180 MHz to 0.1 MHz and <math>VBW_{res}</math> Typical value from 210 MHz to 0.1 MHz; modified Footnote 1 to reflect limited device capability regarding wide video bandwidth, Typical Performance table, p. 4</li> </ul>  |
| 2.1      | Mar. 2012  | <ul style="list-style-type: none"> <li>• Table 3, ESD Protection Characteristics, removed the word “Minimum” after the ESD class rating. ESD ratings are characterized during new product development but are not 100% tested during production. ESD ratings provided in the data sheet are intended to be used as a guideline when handling ESD sensitive devices, p. 2</li> </ul>   |
| 3        | Dec. 2013  | <ul style="list-style-type: none"> <li>• Table 6, Test Circuit Component Designations and Values: updated PCB description to reflect most current board specifications from Rogers, p. 5</li> <li>• Replaced Case Outline 98ASA10760D, Rev. O with Rev. A, pp. 9-11. Mechanical outline drawing modified to reflect the correct lead end features. Format of the mechanical outline was also updated to the current Freescale format for Freescale mechanical outlines.</li> </ul>  |

### ***How to Reach Us:***

**Home Page:**  
[freescale.com](http://freescale.com)

**Web Support:**  
[freescale.com/support](http://freescale.com/support)

Information in this document is provided solely to enable system and software implementers to use Freescale products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits based on the information in this document.

Freescale reserves the right to make changes without further notice to any products herein. Freescale makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale data sheets and/or specifications can and do vary in different applications, and actual performance may vary over time. All operating parameters, including "typicals," must be validated for each customer application by customer's technical experts. Freescale does not convey any license under its patent rights nor the rights of others. Freescale sells products pursuant to standard terms and conditions of sale, which can be found at the following address: [freescale.com/SalesTermsandConditions](http://freescale.com/SalesTermsandConditions).

Freescale and the Freescale logo are trademarks of Freescale Semiconductor, Inc., Reg. U.S. Pat. & Tm. Off. All other product or service names are the property of their respective owners.

© 2009, 2011–2013 Freescale Semiconductor, Inc.

# Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

[Freescale Semiconductor:](#)

[MW7IC008NT1](#)